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Applicant(s)/Patent under Reexamination

10/722,694

Ted M. Wang

Examiner

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KOHLI ET AL. Art Unit

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SEARCH NOT (INCLUDING SEARCH)
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EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	11/21/2006	TW
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